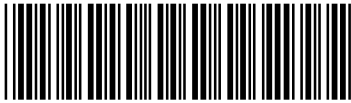


**Search Notes**

Application/Control No.

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Examiner

Trinh T. Nguyen

Applicant(s)/Patent under  
Reexamination

HOLMERTZ ET AL.

Art Unit

3644

**SEARCHED**

Class	Subclass	Date	Examiner
updated	previous	5/3/2009	TTN
	searches		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR